



RADIO TEST REPORT

Test Report No. : 13127992H-A-R1

Applicant : Honda Lock Mfg. Co., Ltd.
Type of Equipment : ECU of 2R SMART SYSTEM
Model No. : HLSS-5A
FCC ID : MLBHLSS-5A
Test regulation : FCC Part 15 Subpart C: 2019
Test Result : Complied (Refer to SECTION 3.2)

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2. The results in this report apply only to the sample tested.
3. This sample tested is in compliance with above regulation.
4. The test results in this report are traceable to the national or international standards.
5. This test report covers Radio technical requirements. It does not cover administrative issues such as Manual or non-Radio test related Requirements. (if applicable)
6. The all test items in this test report are conducted by UL Japan, Inc. Ise EMC Lab.
7. This test report must not be used by the customer to claim product certification, approval, or endorsement by NVLAP, NIST, or any agency of the U.S.A. Government.
8. The information provided from the customer for this report is identified in SECTION 1.
9. This report is a revised version of 13127992H-A. 13127992H-A is replaced with this report.

Date of test: December 10, 2019

Representative test engineer:

K. Yamamoto

Koji Yamamoto

Engineer

Consumer Technology Division

Approved by:

S. Miyazono

Shinichi Miyazono

Engineer

Consumer Technology Division



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☒ There is no testing item of "Non-accreditation".

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Report Cover Page - 13-EM-F0429 Issue # 15.0

REVISION HISTORY

Original Test Report No.: 13127992H-A

Revision	Test report No.	Date	Page revised	Contents
- (Original)	13127992H-A	January 17, 2020	-	-
1	13127992H-A-R1	February14, 2020	P.6	Correction of the worst margin of Electric Field Strength of Fundamental Emission in Clause 3.2; From 23.20 dB to 23.21 dB
1	13127992H-A-R1	February14, 2020	P.7	Correction of test Item in the Uncertainty table of Clause 3.4; From -20 dB Bandwidth to -26 dB Bandwidth
1	13127992H-A-R1	February14, 2020	P.15	Correction of Result value (0.1250 MHz) of PK and PK with duty factor; From 2.40 dBuV/m to 2.39 dBuV/m
1	13127992H-A-R1	February14, 2020	P.15	Correction of Frequency notation of the “Result of the fundamental emission at 3m without Distance factor”; From 0.12500 to 0.1250

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Reference: Abbreviations (Including words undescribed in this report)

A2LA	The American Association for Laboratory Accreditation	MCS	Modulation and Coding Scheme
AC	Alternating Current	MRA	Mutual Recognition Arrangement
AFH	Adaptive Frequency Hopping	N/A	Not Applicable
AM	Amplitude Modulation	NIST	National Institute of Standards and Technology
Amp, AMP	Amplifier	NS	No signal detect.
ANSI	American National Standards Institute	NSA	Normalized Site Attenuation
Ant, ANT	Antenna	NVLAP	National Voluntary Laboratory Accreditation Program
AP	Access Point	OBW	Occupied Band Width
ASK	Amplitude Shift Keying	OFDM	Orthogonal Frequency Division Multiplexing
Atten., ATT	Attenuator	P/M	Power meter
AV	Average	PCB	Printed Circuit Board
BPSK	Binary Phase-Shift Keying	PER	Packet Error Rate
BR	Bluetooth Basic Rate	PHY	Physical Layer
BT	Bluetooth	PK	Peak
BT LE	Bluetooth Low Energy	PN	Pseudo random Noise
BW	BandWidth	PRBS	Pseudo-Random Bit Sequence
Cal Int	Calibration Interval	PSD	Power Spectral Density
CCK	Complementary Code Keying	QAM	Quadrature Amplitude Modulation
Ch., CH	Channel	QP	Quasi-Peak
CISPR	Comite International Special des Perturbations Radioelectriques	QPSK	Quadri-Phase Shift Keying
CW	Continuous Wave	RBW	Resolution Band Width
DBPSK	Differential BPSK	RDS	Radio Data System
DC	Direct Current	RE	Radio Equipment
D-factor	Distance factor	RF	Radio Frequency
DFS	Dynamic Frequency Selection	RMS	Root Mean Square
DQPSK	Differential QPSK	RSS	Radio Standards Specifications
DSSS	Direct Sequence Spread Spectrum	Rx	Receiving
EDR	Enhanced Data Rate	SA, S/A	Spectrum Analyzer
EIRP, e.i.r.p.	Equivalent Isotropically Radiated Power	SG	Signal Generator
EMC	ElectroMagnetic Compatibility	SVSWR	Site-Voltage Standing Wave Ratio
EMI	ElectroMagnetic Interference	TR	Test Receiver
EN	European Norm	Tx	Transmitting
ERP, e.r.p.	Effective Radiated Power	VBW	Video BandWidth
EU	European Union	Vert.	Vertical
EUT	Equipment Under Test	WLAN	Wireless LAN
Fac.	Factor		
FCC	Federal Communications Commission		
FHSS	Frequency Hopping Spread Spectrum		
FM	Frequency Modulation		
Freq.	Frequency		
FSK	Frequency Shift Keying		
GFSK	Gaussian Frequency-Shift Keying		
GNSS	Global Navigation Satellite System		
GPS	Global Positioning System		
Hori.	Horizontal		
ICES	Interference-Causing Equipment Standard		
IEC	International Electrotechnical Commission		
IEEE	Institute of Electrical and Electronics Engineers		
IF	Intermediate Frequency		
ILAC	International Laboratory Accreditation Conference		
ISED	Innovation, Science and Economic Development Canada		
ISO	International Organization for Standardization		
JAB	Japan Accreditation Board		
LAN	Local Area Network		
LIMS	Laboratory Information Management System		

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SECTION 1: Customer information

[Applicant]

Company Name	:	Honda Lock Mfg. Co., Ltd.
Address	:	3700 Shimonaka, Sadowara-Cho, Miyazaki-Shi, Miyazaki, 880-0293, Japan
Telephone Number	:	+81-50-3757-3759
Facsimile Number	:	+81-985-73-5197
Contact Person	:	Shinichuro Eto

[Manufacturer]

Company Name	:	Honda Lock Vietnam Co., Ltd.
Address	:	Dong Van II Industrial Zone, Bach Thuong Ward, Duy Tien District, Ha Nam Province, Vietnam

The information provided from the customer is as follows;

- Applicant, Type of Equipment, Model No. FCC ID on the cover and other relevant pages
 - Operating/Test Mode(s) (Mode(s)) on all the relevant pages
 - SECTION 1: Customer information
 - SECTION 2: Equipment under test (E.U.T.)
 - SECTION 4: Operation of E.U.T. during testing
- * The laboratory is exempted from liability of any test results affected from the above information in SECTION 2 and 4.

SECTION 2: Equipment under test (E.U.T.)

2.1 Identification of E.U.T.

Type of Equipment	:	ECU of 2R SMART SYSTEM
Model No.	:	HLSS-5A
Serial No.	:	Refer to Section 4, Clause 4.2
Rating	:	DC 12.0 V
Receipt Date of Sample (Information from test lab.)	:	September 19, 2019
Country of Mass-production	:	Vietnam
Condition of EUT	:	Production prototype (Not for Sale: This sample is equivalent to mass-produced items.)
Modification of EUT	:	No Modification by the test lab

2.2 Product Description

Model No: HLSS-5A (referred to as the EUT in this report), is the ECU of 2R SMART SYSTEM.

Radio Specification

[Transmitter]

Radio Type	:	Transceiver
Frequency of Operation	:	125 kHz
Modulation	:	ASK
Antenna type	:	Ferrite coil antenna
Clock frequency (Maximum)	:	10 MHz

[Receiver]

Radio Type	:	Receiver
Frequency of Operation	:	433.92 MHz

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SECTION 3: Test specification, procedures & results

3.1 Test Specification

Test Specification : FCC Part 15 Subpart C
FCC Part 15 final revised on July 19, 2019 and effective August 19, 2019 except 15.258

Title : FCC 47CFR Part15 Radio Frequency Device Subpart C Intentional Radiators
Section 15.207 Conducted limits
Section 15.209 Radiated emission limits; general requirements.

* Also the EUT complies with FCC Part 15 Subpart B.

3.2 Procedures and results

Item	Test Procedure	Specification	Remarks	Deviation	Worst margin	Results	Remarks
Conducted Emission	<FCC> ANSI C63.10:2013 6 Standard test methods <ISED> RSS-Gen 8.8	<FCC> Section 15.207 <ISED> RSS-Gen 8.8	-	N/A	N/A	N/A	*1)
Electric Field Strength of Fundamental Emission	<FCC> ANSI C63.10:2013 6 Standard test methods <ISED> RSS-Gen 6.5, 6.12	<FCC> Section 15.209 <ISED> RSS-210 4.4 RSS-Gen 8.9	Radiated	N/A	23.21 dB 125 kHz 0 deg. PK with Duty Factor	Complied a)	-
Electric Field Strength of Spurious Emission	<FCC> ANSI C63.10:2013 6 Standard test methods <ISED> RSS-Gen 6.5, 6.6, 6.13	<FCC> Section 15.209 <ISED> RSS-210 4.4 RSS-Gen 8.9	Radiated	N/A	21.5 dB 842.255 MHz, Horizontal, QP	Complied a)	-
-26 dB Bandwidth	<FCC> ANSI C63.10:2013 6 Standard test methods <ISED> -	<FCC> Reference data <ISED> -	Radiated	N/A	N/A	Complied b)	-

Note: UL Japan, Inc.'s EMI Work Procedures No. 13-EM-W0420 and 13-EM-W0422.

*1) The test is not applicable since the EUT is not the device that is designed to be connected to the public utility (AC) power line.

a) Refer to APPENDIX 1 (data of Radiated emission)

b) Refer to APPENDIX 1 (data of -26 dB Bandwidth and 99 % Occupied Bandwidth)

Symbols:

Complied The data of this test item has enough margin, more than the measurement uncertainty.

Complied# The data of this test item meets the limits unless the measurement uncertainty is taken into consideration.

FCC Part 15.31 (e)

This test was performed with the New Battery (DC 12 V) and the constant voltage was supplied to this EUT during the tests. Therefore, this EUT complies with the requirement.

FCC Part 15.203 Antenna requirement

It is impossible for end users to replace the antenna, because the antenna is mounted inside of the EUT. Therefore, the equipment complies with the antenna requirement of Section 15.203.

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3.3 Addition to standard

Item	Test Procedure	Specification	Remarks	Deviation	Worst margin	Results
99 % Occupied Band Width	RSS-Gen 6.7	-	Radiated	N/A	N/A	-
Note: UL Japan, Inc.'s EMI Work Procedures No. 13-EM-W0420 and 13-EM-W0422.						

Other than above, no addition, exclusion nor deviation has been made from the standard.

3.4 Uncertainty

There is no applicable rule of uncertainty in this applied standard. Therefore, the following results are derived depending on whether or not laboratory uncertainty is applied.

The following uncertainties have been calculated to provide a confidence level of 95% using a coverage factor k=2.

Radiated emission

Measurement distance	Frequency range	Uncertainty (+/-)
3 m	9 kHz to 30 MHz	3.3 dB
10 m		3.2 dB
3 m	30 MHz to 200 MHz (Horizontal)	4.8 dB
		5.0 dB
	200 MHz to 1000 MHz (Horizontal)	5.2 dB
		6.3 dB
10 m	30 MHz to 200 MHz (Horizontal)	4.8 dB
		4.8 dB
	200 MHz to 1000 MHz (Horizontal)	5.0 dB
		5.0 dB
3 m	1 GHz to 6 GHz	4.9 dB
	6 GHz to 18 GHz	5.2 dB
1 m	10 GHz to 26.5 GHz	5.5 dB
	26.5 GHz to 40 GHz	5.5 dB
10 m	1 GHz to 18 GHz	5.2 dB

Antenna Terminal test

Test Item	Uncertainty (+/-)
-26 dB Bandwidth / 99 % Occupied Bandwidth	0.96 %

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3.5 Test Location

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*NVLAP Lab. code: 200572-0 / FCC Test Firm Registration Number: 199967 / ISED Lab Company Number: 2973C

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Test site	Width x Depth x Height (m)	Size of reference ground plane (m) / horizontal conducting plane	Other rooms	Maximum measurement distance
No.1 semi-anechoic chamber	19.2 x 11.2 x 7.7	7.0 x 6.0	No.1 Power source room	10 m
No.2 semi-anechoic chamber	7.5 x 5.8 x 5.2	4.0 x 4.0	-	3 m
No.3 semi-anechoic chamber	12.0 x 8.5 x 5.9	6.8 x 5.75	No.3 Preparation room	3 m
No.3 shielded room	4.0 x 6.0 x 2.7	N/A	-	-
No.4 semi-anechoic chamber	12.0 x 8.5 x 5.9	6.8 x 5.75	No.4 Preparation room	3 m
No.4 shielded room	4.0 x 6.0 x 2.7	N/A	-	-
No.5 semi-anechoic chamber	6.0 x 6.0 x 3.9	6.0 x 6.0	-	-
No.5 measurement room	6.4 x 6.4 x 3.0	6.4 x 6.4	-	-
No.6 shielded room	4.0 x 4.5 x 2.7	4.0 x 4.5	-	-
No.6 measurement room	4.75 x 5.4 x 3.0	4.75 x 4.15	-	-
No.7 shielded room	4.7 x 7.5 x 2.7	4.7 x 7.5	-	-
No.8 measurement room	3.1 x 5.0 x 2.7	3.1 x 5.0	-	-
No.9 measurement room	8.8 x 4.6 x 2.8	2.4 x 2.4	-	-
No.11 measurement room	6.2 x 4.7 x 3.0	4.8 x 4.6	-	-

* Size of vertical conducting plane (for Conducted Emission test) : 2.0 x 2.0 m for No.1, No.2, No.3, and No.4 semi-anechoic chambers and No.3 and No.4 shielded rooms.

3.6 Test data, Test instruments, and Test set up

Refer to APPENDIX.

SECTION 4: Operation of E.U.T. during testing

4.1 Operating Modes

Test mode	Remarks
Transmitting mode	-
*EUT was set by the software as follows; Software: MKR-8B_LF Version 1.0.0 (Date: 2019.09.07, Storage location: IC100) *This setting of software is the worst case. Any conditions under the normal use do not exceed the condition of setting. In addition, end users cannot change the settings of the output power of the product.	

Justification : The system was configured in typical fashion (as a user would normally use it) for testing.

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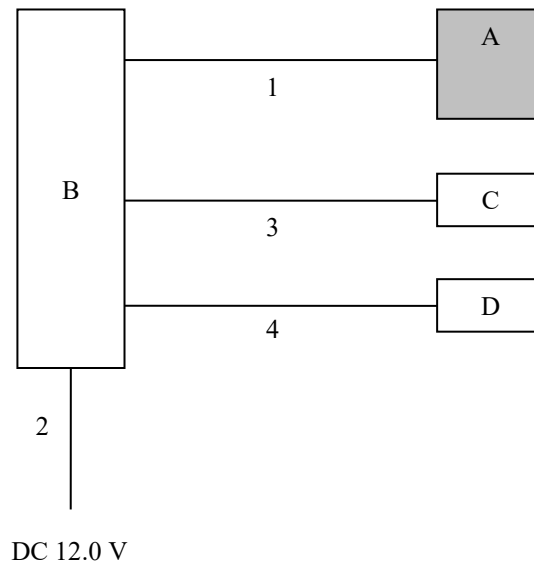
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4.2 Configuration and peripherals



* Cabling and setup(s) were taken into consideration and test data was taken under worse case conditions.

Description of EUT and Support equipment

No.	Item	Model number	Serial number	Manufacturer	Remarks
A	ECU of 2R SMART SYSTEM	HLSS-5A	001	Honda Lock Vietnam Co., Ltd.	EUT
B	Switch BOX	-	-	Honda Lock Mfg. Co., Ltd.	-
C	Dummy ESL	-	-	Honda Lock Mfg. Co., Ltd.	-
D	Relay	-	-	Honda Lock Mfg. Co., Ltd.	-

List of cables used

No.	Name	Length (m)	Shield		Remarks
			Cable	Connector	
1	DC & Signal Cable	0.7	Unshielded	Unshielded	-
2	DC Cable	1.5	Unshielded	Unshielded	-
3	Signal Cable	0.6	Unshielded	Unshielded	-
4	Signal Cable	0.5	Unshielded	Unshielded	-

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SECTION 5: Radiated emission (Fundamental and Spurious Emission)

Test Procedure

EUT was placed on a urethane platform of nominal size, 1.0 m by 1.5 m, raised 0.8 m above the conducting ground plane.

The Radiated Electric Field Strength has been measured in a Semi Anechoic Chamber with a ground plane.

Frequency : From 9 kHz to 30 MHz

The EUT was rotated a full revolution in order to obtain the maximum value of the electric field intensity.

The measurements were performed for vertical polarization (antenna angle: 0 deg., 45 deg., 90 deg., and 180 deg.) and horizontal polarization.

*Refer to Figure 1 about Direction of the Loop Antenna.

Frequency: From 30 MHz to 1 GHz

The measuring antenna height varied between 1 and 4 m and EUT was rotated a full revolution in order to obtain the maximum value of the electric field intensity.

The measurements were performed for both vertical and horizontal antenna polarization.

The test was made with the detector (RBW / VBW) in the following table.

When using Spectrum analyzer, the test was made with adjusting span to zero by using peak hold.

Test Antennas are used as below;

Frequency	Below 30 MHz	30 MHz to 200 MHz	200 MHz to 1 GHz
Antenna Type	Loop	Biconical	Logperiodic

Frequency	From 9 kHz to 90 kHz and From 110 kHz to 150 kHz	From 90 kHz to 110 kHz	From 150 kHz to 490 kHz	From 490 kHz to 30 MHz	From 30 MHz to 1 GHz
Instrument used	Test Receiver				
Detector	PK / AV	QP	PK / AV	QP	QP
IF Bandwidth	200 Hz	200 Hz	9 kHz	9 kHz	120 kHz
Test Distance	3 m *1)	3 m *1)	3 m *1)	3 m *2)	3 m

*1) Distance Factor: $40 \times \log (3 \text{ m} / 300 \text{ m}) = -80 \text{ dB}$

*2) Distance Factor: $40 \times \log (3 \text{ m} / 30 \text{ m}) = -40 \text{ dB}$

Although these tests were performed other than open field test site, adequate comparison measurements were confirmed against 30 m open field test site. Therefore sufficient tests were made to demonstrate that the alternative site produces results that correlate with the ones of tests made in an open field based on KDB 414788.

These tests were performed in semi anechoic chamber. Therefore the measured level of emissions may be higher than if measurements were made without a ground plane.

However test results were confirmed to pass against standard limit.

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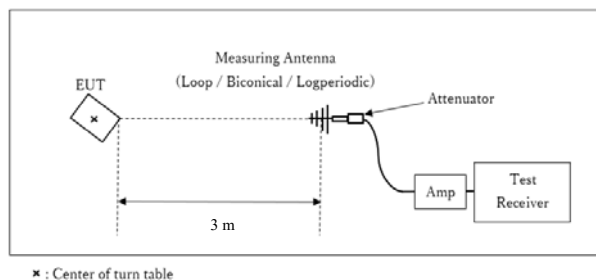
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[Test Setup]
Below 1 GHz



Test Distance: 3 m

- The carrier level and noise levels were confirmed at each position of X, Y and Z axes of EUT to see the position of maximum noise, and the test was made at the position that has the maximum noise.

The test results and limit are rounded off to one decimal place, so some differences might be observed.

Measurement range : 9 kHz - 1 GHz
Test data : APPENDIX 1
Test result : Pass

Date: December 10, 2019

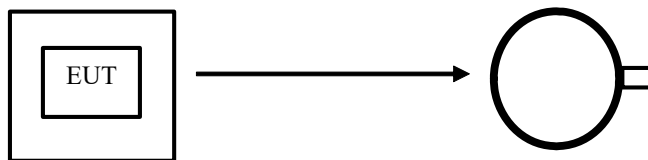
Test engineer: Koji Yamamoto

Figure 1: Direction of the Loop Antenna

Side View (Vertical)

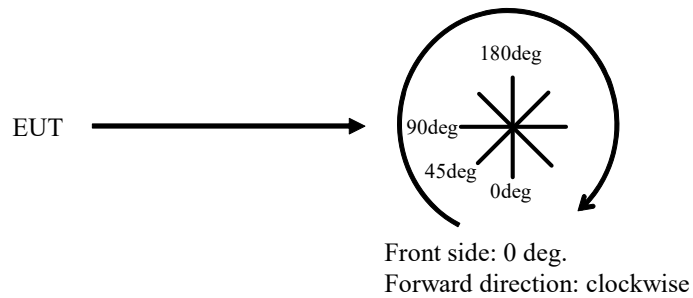


Top View (Horizontal)



Antenna was not rotated.

Top View (Vertical)



SECTION 6: -26 dB Bandwidth

Test Procedure

The test was measured with a spectrum analyzer using a test fixture.

Test	Span	RBW	VBW	Sweep	Detector	Trace	Instrument used
-26 dB Bandwidth	50 kHz	510 Hz	1.5 kHz	Auto	Peak	Max Hold	Spectrum Analyzer

Test data : APPENDIX 1

Test result : Pass

SECTION 7: 99 % Occupied Bandwidth

Test Procedure

The test was measured with a spectrum analyzer using a test fixture.

Test	Span	RBW	VBW	Sweep	Detector	Trace	Instrument used
99 % Occupied Bandwidth	Enough width to display emission skirts	1 to 5 % of OBW	Three times of RBW	Auto	Peak *1)	Max Hold *1)	Spectrum Analyzer

*1) The measurement was performed with Peak detector, Max Hold since the duty cycle was not 100 %.
Peak hold was applied as Worst-case measurement.

Test data : APPENDIX 1

Test result : Pass

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APPENDIX 1: Test data

Radiated Emission below 30 MHz (Fundamental and Spurious Emission)

Report No. 13127992H
Test place Ise EMC Lab.
Semi Anechoic Chamber No.4
Date December 10, 2019
Temperature / Humidity 22 deg. C / 34 % RH
Engineer Koji Yamamoto
Mode Tx 125kHz

PK or QP

Ant Deg [deg] or Polarity [Hori/Vert]	Frequency [MHz]	Detector	Reading [dBuV]	Ant Factor [dB/m]	Loss [dB]	Gain [dB]	Duty Factor [dB]	Result [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Remark
0deg	0.1250	PK	88.30	19.94	-73.61	32.23	-	2.39	45.60	43.21	Fundamental
0deg	0.2500	PK	64.00	19.89	-73.59	32.19	-	-21.89	39.60	61.49	
0deg	0.3750	PK	62.40	19.85	-73.58	32.16	-	-23.49	36.10	59.59	
0deg	0.5000	QP	40.00	19.80	-33.57	32.13	-	-5.90	33.60	39.50	
0deg	0.6250	QP	51.60	19.79	-33.56	32.15	-	5.68	31.70	26.02	
0deg	0.7500	QP	34.20	19.79	-33.54	32.17	-	-11.72	30.10	41.82	
0deg	0.8750	QP	46.30	19.78	-33.53	32.19	-	0.36	28.70	28.34	
0deg	1.0000	QP	30.90	19.77	-33.52	32.21	-	-15.06	27.60	42.66	
0deg	1.1250	QP	41.20	19.77	-33.51	32.21	-	-4.75	26.50	31.25	
0deg	1.2500	QP	30.80	19.77	-33.50	32.21	-	-15.14	25.60	40.74	

Result = Reading + Ant Factor + Loss (Cable + Attenuator + Filter + D.Factor) - Gain(Amplifier)

PK with Duty factor

Ant Deg [deg]	Frequency [MHz]	Detector	Reading [dBuV]	Ant Factor [dB/m]	Loss [dB]	Gain [dB]	Duty Factor [dB]	Result [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Remark
0deg	0.1250	PK	88.30	19.94	-73.61	32.23	0.0	2.39	25.60	23.21	
0deg	0.2500	PK	64.00	19.89	-73.59	32.19	0.0	-21.89	19.60	41.49	
0deg	0.3750	PK	62.40	19.85	-73.58	32.16	0.0	-23.49	16.10	39.59	

Result = Reading + Ant Factor + Loss (Cable + Attenuator + Filter + D.Factor) - Gain(Amplifier) + Duty factor *

* Since the peak emission result satisfied the average limit, duty factor was omitted.

Result of the fundamental emission at 3m without Distance factor

PK or QP

Ant Deg [deg]	Frequency [MHz]	Detector	Reading [dBuV]	Ant Factor [dB/m]	Loss [dB]	Gain [dB]	Duty Factor [dB]	Result [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Remark
0	0.1250	PK	88.30	19.94	6.38	32.23	-	82.39	-	-	Fundamental

Result = Reading + Ant Factor + Loss (Cable+Attenuator+Filter) - Gain(Amplifier)

* Other frequency noises omitted in this report were not seen or had enough margin (more than 20 dB).

*The test result is rounded off to one or two decimal places, so some differences might be observed.

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Radiated Emission above 30 MHz (Spurious Emission)

Report No. 13127992H
Test place Ise EMC Lab.
Semi Anechoic Chamber No.4
Date December 10, 2019
Temperature / Humidity 22 deg. C / 34 % RH
Engineer Koji Yamamoto
Mode Tx 125kHz

Polarity	Frequency [MHz]	Detector	Reading [dBuV]	Ant.Fac. [dB/m]	Loss [dB]	Gain [dB]	Result [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Remark
Hori.	82.632	QP	22.6	7.3	8.2	32.1	6.0	40.0	34.0	
Hori.	103.480	QP	23.9	10.8	8.5	32.1	11.0	43.5	32.5	
Hori.	240.710	QP	26.7	11.6	9.7	32.0	16.0	46.0	30.0	
Hori.	258.522	QP	28.8	12.2	9.8	31.9	18.9	46.0	27.1	
Hori.	588.887	QP	21.7	19.0	11.9	32.1	20.5	46.0	25.5	
Hori.	842.255	QP	21.6	21.2	13.1	31.4	24.5	46.0	21.5	
Vert.	59.383	QP	22.4	8.0	7.9	32.2	6.2	40.0	33.9	
Vert.	163.474	QP	21.8	15.5	9.1	32.0	14.3	43.5	29.2	
Vert.	255.355	QP	23.1	12.1	9.8	32.0	13.0	46.0	33.0	
Vert.	305.537	QP	21.8	13.6	10.2	31.9	13.7	46.0	32.4	
Vert.	554.794	QP	21.8	18.0	11.7	32.0	19.5	46.0	26.5	
Vert.	768.501	QP	22.1	20.4	12.8	31.8	23.5	46.0	22.5	

Result = Reading + Ant Factor + Loss (Cable+Attenuator) - Gain(Amplifier)

*Other frequency noises omitted in this report were not seen or had enough margin (more than 20 dB).

*The test result is rounded off to one or two decimal places, so some differences might be observed.

UL Japan, Inc.

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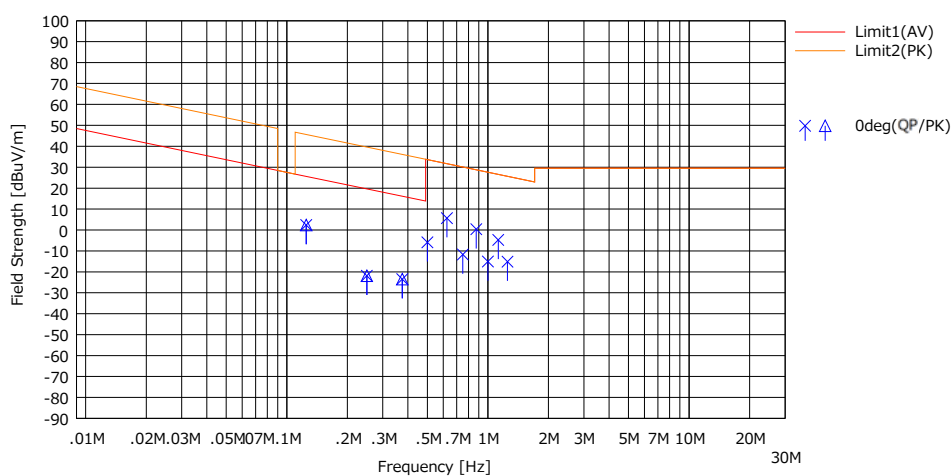
Facsimile : +81 596 24 8124

Radiated Emission Plot data, Worst case

Report No. 13127992H
Test place Ise EMC Lab.
Semi Anechoic Chamber No.4
Date December 10, 2019
Temperature / Humidity 22 deg. C / 34 % RH
Engineer Koji Yamamoto
Mode Tx 125kHz

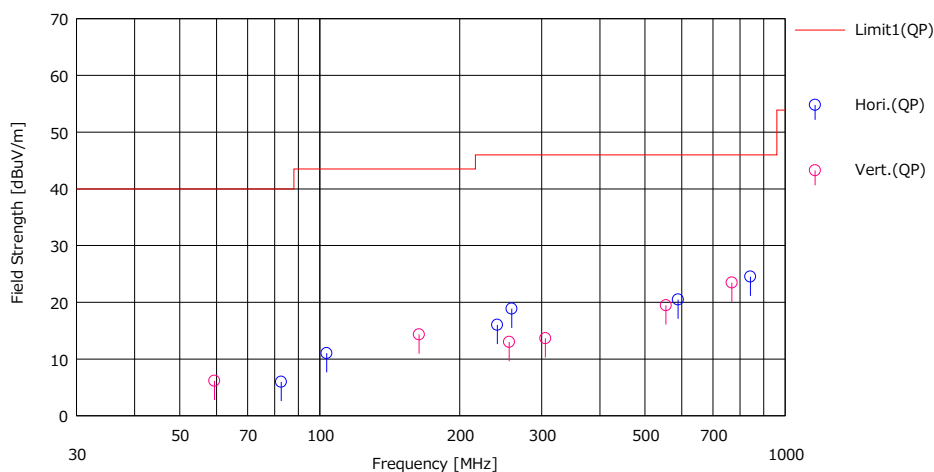
(below 30MHz)

Limit : FCC15.209(a), 9-90kHz:PK, 110-490kHz:PK, other:QP



* Data above 490 kHz were measured using a QP detector.

Limit : FCC15.209 3 m, below 1 GHz:QP, above 1 GHz:AV/PK



(above 30MHz)

*These plots data contains sufficient number to show the trend of characteristic features for EUT.

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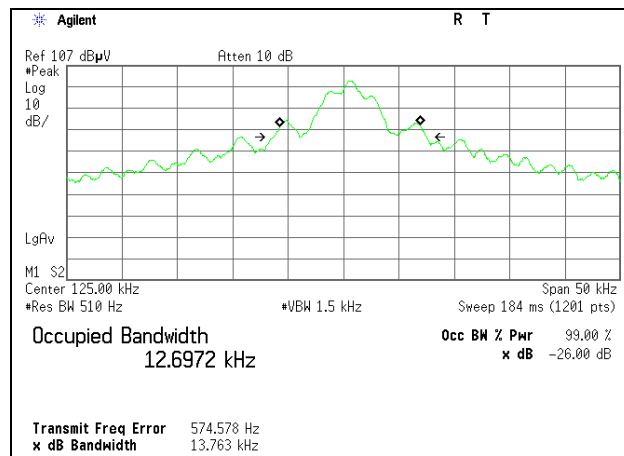
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-26 dB Bandwidth and 99 % Occupied Bandwidth

Report No. 13127992H
Test place Ise EMC Lab.
Semi Anechoic Chamber No.4
Date December 10, 2019
Temperature / Humidity 22 deg. C / 34 % RH
Engineer Koji Yamamoto
Mode Tx 125kHz

-26 dB Bandwidth [kHz]	99 % Occupied Bandwidth [kHz]
13.763	12.6972



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APPENDIX 2: Test instruments

Test Instruments

Test item	LIMS ID	Description	Manufacturer	Model	Serial	Last Calibration Date	Calibration Due Date	Cal Int
RE	141425	Biconical Antenna	Schwarzbeck	VHA9103+BBA9106	1302	08/24/2019	08/31/2020	12
RE	141562	Thermo-Hygrometer	CUSTOM	CTH-201	0010	01/11/2019	01/31/2020	12
RE	142011	AC4_Semi Anechoic Chamber(NSA)	TDK	Semi Anechoic Chamber 3m	DA-10005	06/28/2018	06/30/2020	24
RE	141533	DIGITAL HiTESTER	HIOKI	3805	51201195	01/29/2019	01/31/2020	12
RE	142227	Measure	KOMELON	KMC-36	-	-	-	-
RE	141397	Coaxial Cable	UL Japan	-	-	06/18/2019	06/30/2020	12
RE	141267	Logperiodic Antenna (200-1000MHz)	Schwarzbeck	VUSLP9111B	9111B-192	08/24/2019	08/31/2020	12
RE	141950	EMI Test Receiver	Rohde & Schwarz	ESU26	100412	06/27/2019	06/30/2020	12
RE	141884	Spectrum Analyzer	AGILENT	E4448A	MY44020357	03/13/2019	03/31/2020	12
RE	141217	Coaxial cable	Fujikura/Suhner/TSJ	5D-2W/SFM141/421-010/sucoform141-P	-/04178	06/18/2019	06/30/2020	12
RE	141413	Coaxial Cable	UL Japan	-	-	06/07/2019	06/30/2020	12
RE	141254	Loop Antenna	Rohde & Schwarz	HFH2-Z2	100017	10/04/2019	10/31/2020	12
RE	141331	Attenuator(6dB)	TME	UFA-01	-	02/05/2019	02/29/2020	12
RE	141583	Pre Amplifier	SONOMA INSTRUMENT	310	260833	02/08/2019	02/29/2020	12

*Hyphens for Last Calibration Date, Calibration Due Date and Cal Int (month) are instruments that Calibration is not required (e.g. software), or instruments checked in advance before use.

The expiration date of the calibration is the end of the expired month.

All equipment is calibrated with valid calibrations. Each measurement data is traceable to the national or international standards.

As for some calibrations performed after the tested dates, those test equipment have been controlled by means of an unbroken chains of calibrations.

Test item:

RE: Spurious emission

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